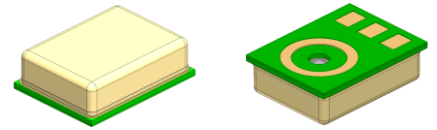


HIGH SNR, HIGH AOP ANALOG BOTTOM PORT SISONIC™ MICROPHONE

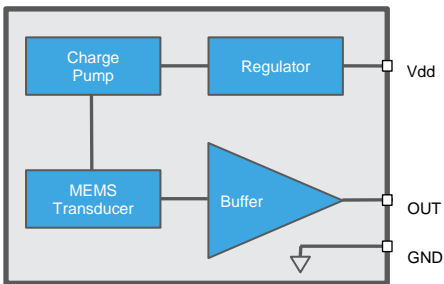


The SPK01A0LR5H-1 is a high Signal-to-Noise Ratio (SNR), high Acoustic Overload Point (AOP), bottom port silicon microphone. Using Knowles' proven high performance SiSonic™ MEMS technology, the SPK01A0LR5H-1 consists of an acoustic sensor, a low noise input buffer, and a single ended output amplifier. This microphone's high SNR enables enhanced consumer experience with Transparency Mode & Active Noise Cancellation on Ear Products. Its high SNR & AOP provide high dynamic range for a variety of IoT products in a small form factor. The microphone's low phase distortion lends to superior algorithm performance.



PRODUCT FEATURES

- Single-Ended Output
- Low Distortion /High AOP
- High SNR
- Flat Frequency Response
- Low Current
- Sensitivity Matching
- Bottom Port
- Ultra-Stable Performance
- Omnidirectional
- Standard SMD Reflow
- LGA Package



ABSOLUTE MAXIMUM RATINGS

Table 1: Absolute Maximum Ratings

Parameter	Absolute Maximum Rating	Units
Vdd to Ground	-0.3, +5.0	V
OUT to Ground	-0.3, Vdd+0.3	V
Input Current	±5	mA
Storage Temperature	-40 to +100	°C
Operating Temperature	-40 to +85	°C

Stresses exceeding these "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only. Functional operation at these or any other conditions beyond those indicated under "Acoustic & Electrical Specifications" is not implied. Exposure beyond those indicated under "Acoustic & Electrical Specifications" for extended periods may affect device reliability.

TYPICAL APPLICATIONS

- Transparency Mode OTE & TWS
- ANC Mode OTE & TWS
- Far field Voice Speakerphone



ACOUSTIC & ELECTRICAL SPECIFICATIONS¹

Table 2: General Microphone Specifications

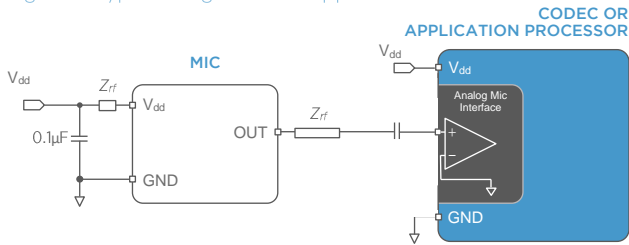
Test Conditions: 23 ±2°C, 55±20% R.H., Vdd=2.75V, no load, unless otherwise indicated

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Supply Voltage	Vdd		2.3	2.75	3.6	V
Supply Current	Idd	Vdd = 3.6 V	-	180	-	µA
		Vdd = 2.75 V	-	175	200	
Sensitivity	S	94 dB SPL @ 1kHz	-39	-38	-37	dBV/Pa
Signal to Noise Ratio	SNR	94 dB SPL @ 1kHz, A-weighted	-	71.8	-	dBV/Pa
Near-Ultrasonic SNR		94 dB SPL, @ 19 kHz, BW = 18.5 - 20.0 kHz	-	84	-	dB
Total Harmonic Distortion	THD	94 dB SPL @ 1 kHz	-	0.1	-	%
		115 dB SPL @ 1 kHz	-	0.5	-	
		1% THD @ 1 kHz, S = typ	-	122	-	
Acoustic Overload Point	AOP	10% THD @ 1 kHz, S = typ	-	130	-	dB SPL
Low Frequency Rolloff	LFRO	-3dB relative to 1 kHz	-	17	-	Hz
High Frequency Flatness		+3dB relative to 1 kHz	-	16	-	kHz
Resonant Frequency Peak	Fres		-	28	-	kHz
Power Supply Rejection Ratio	PSRR	200 mVpp sinewave @ 1 kHz, Single-Ended Mode	-	77	-	dB
Power Supply Rejection	PSR+N	200 mVpp 7/8 duty cycle rectangular waveform @ 217 Hz, Vdd = 2.75V, A-weighted, Single-Ended	-	-103	-	dBV(A)
DC Output		Vdd = 2.3 V	-	0.94	-	V
Output Impedance	Zout	@ 1 kHz	-	300	400	Ω
Output Load	Cload		-	-	230	pF
	Rload	AC-coupled	7	-	-	kΩ
Sensitivity Drop		Vdd(min) ≤ Vdd ≤ Vdd(max)	-	-	±0.25	dB
Directivity			Omnidirectional			
Polarity		Increasing sound pressure	Increasing Output Voltage			
Startup Time		S within 1 dB of final value, outputs AC coupled	-	-	15	ms

¹ Sensitivity and Supply Current are 100% tested.



Figure 1: Typical Single-Ended Application Circuit



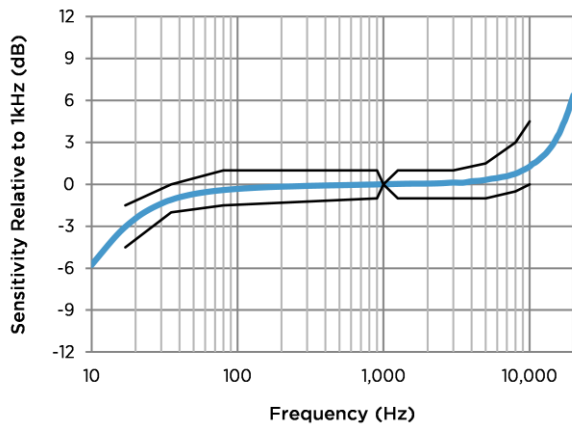
NOTES:

If necessary to improve RF performance, optional series components (resistors, ferrites, etc.) should be placed closest to the microphone pads. Bypass capacitors should be placed near each Vdd pin for best performance. Capacitors near the microphone should not contain Class 2 dielectrics due to their piezoelectric effect. Follow the codec manufacturer's recommendations for circuitry and layout.

PERFORMANCE CURVES

Test Conditions: 23 ±2°C, 55±20% R.H., Vdd=2.75V, no load, unless otherwise indicated

Figure 2: Typical Free Field Magnitude Response and Masks



	17	35	80	900	1000	1250	3000	5000	8000	10000
USL	-1.5	0	1	1	0	1	1	1.5	3	4.5
LSL	-4.5	-2	-1.5	-1	0	-1	-1	-1	-0.5	0

Figure 3: Typical Phase and Group Delay

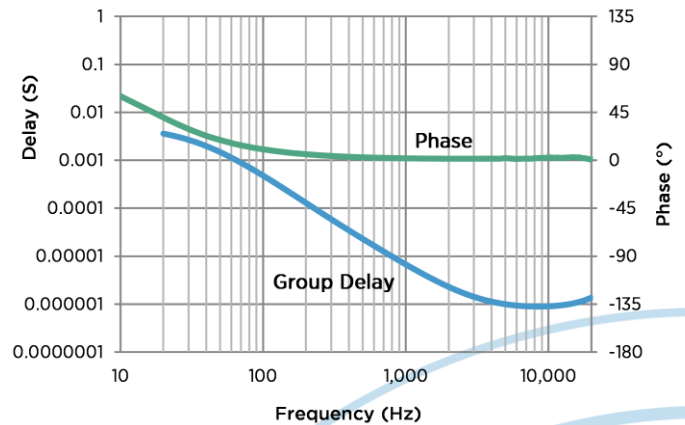


Figure 4: Typical THD vs SPL

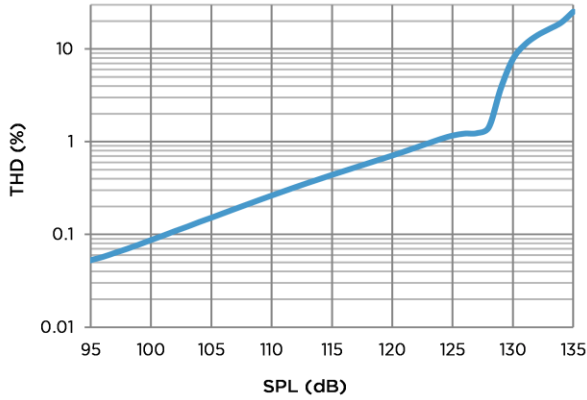


Figure 7: Typical I_{dd} vs V_{dd}

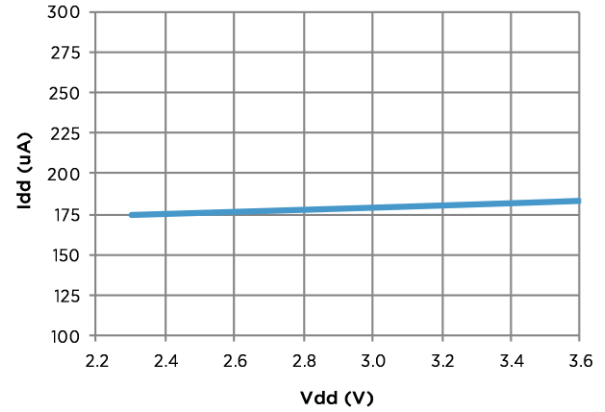


Figure 5: Typical THD vs Frequency

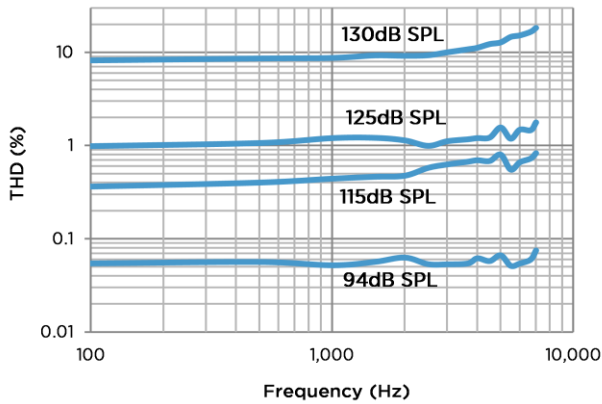


Figure 8: Noise Floor Power Spectral Density

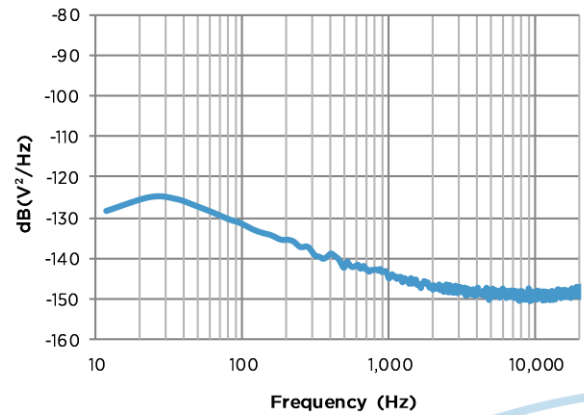


Figure 6: Typical Free Field Ultrasonic Response

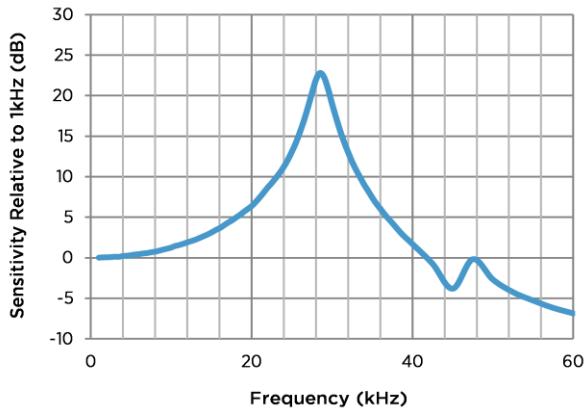
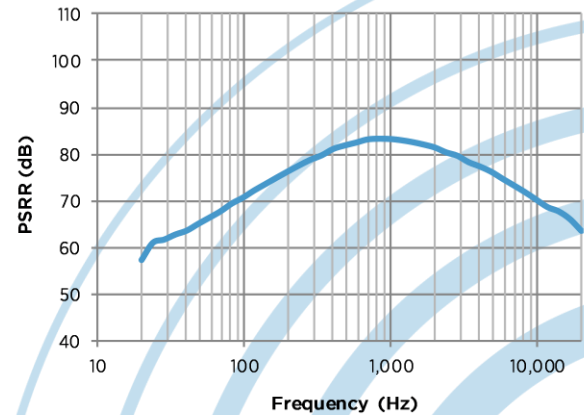
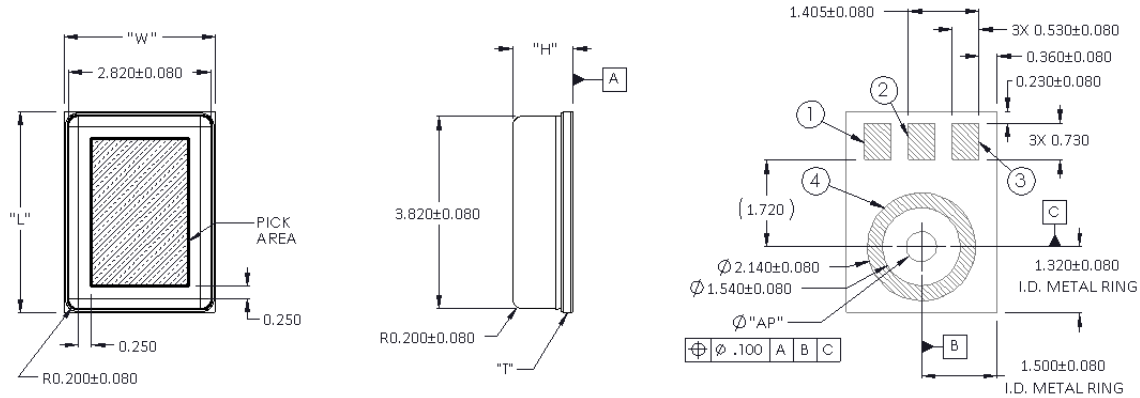


Figure 9: Typical PSRR



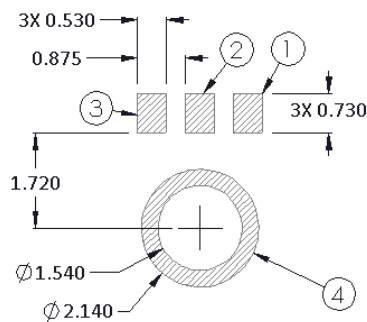
MECHANICAL SPECIFICATIONS



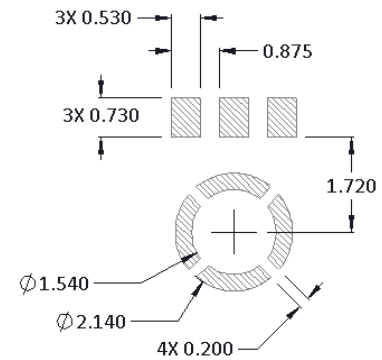
Item	Dimension	Tolerance
Length (L)	4.00	±0.100
Width (W)	3.00	±0.100
Height (H)	1.20	±0.100
Acoustic Port (AP)	Ø0.600	±0.050
PCB Thickness (T)	0.265	±0.050

Pin #	Pin Name	Type	Description
1	Vdd	Power	Power Supply
2	No Connect	N/A	Test Pin - do not place over ground plane
3	OUT	Signal	Output
4	GROUND	Power	Ground

Example Land Pattern



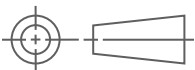
Example Solder Stencil Pattern



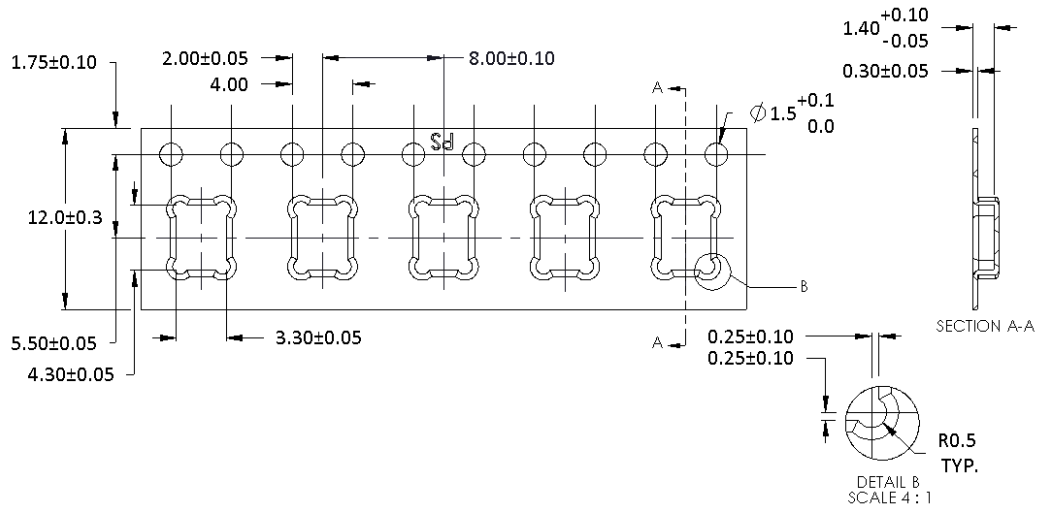
NOTES:

Pick Area only extends to 0.25 mm of any edge or hole unless otherwise specified.
 Dimensions are in millimeters unless otherwise specified.
 Tolerance is ±0.15mm unless otherwise specified.

In the acoustic path, the recommended PCB Hole Diameter is $0.6 \leq D \leq 1.0\text{mm}$, the recommended Gasket Cavity Diameter is $D \geq 1.0\text{mm}$ and the recommended Case Hole Diameter is $1.0 \leq D \leq 1.5\text{mm}$. Further optimizations based on application should be performed.

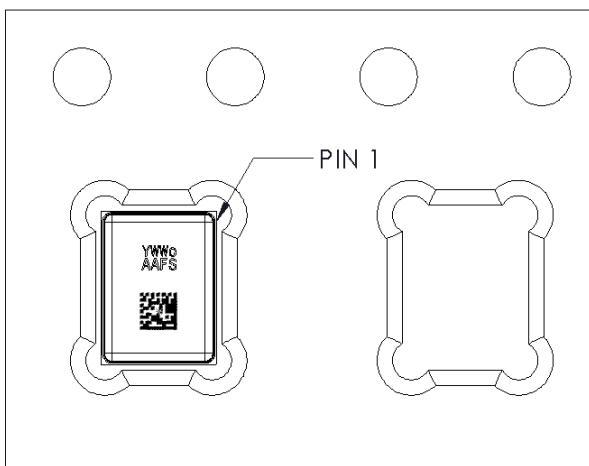


PACKAGING & MARKING DETAIL



Model Number	Suffix	Reel Diameter	Quantity Per Reel
SPK01A0LR5H-1	-7	13"	5700

Component	Surface Resistance (ohms)
Reel	$10^5 - 10^9$
Carrier Tape	$10^5 - 10^9$
Cover Tape	$10^4 - 10^{10}$



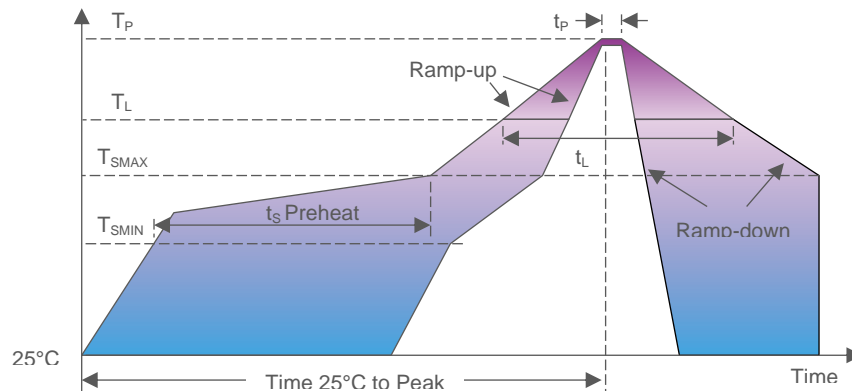
Letter: "o", orientation mark (pin 1)
 AAAAAA = Internal KN Code
 2D barcode "ABCDEFGHJKLMNPQRSTUVWXYZ0123456789":
 Unique Job Identification Number for product traceability

NOTES:

- Dimensions are in millimeters unless otherwise specified.
- Vacuum pickup only in the pick area indicated in Mechanical Specifications.
- Tape & reel per EIA-481.
- Labels applied directly to reel and external package.
- Shelf life: Twelve (12) months when devices are stored in the factory-supplied, unopened ESD moisture sensitive bag under the maximum environmental conditions of 30°C, 70% R.H.



RECOMMENDED REFLOW PROFILE



Profile Feature	Pb-Free
Average Ramp-up rate (T_{SMAX} to T_P)	3°C/second max.
Preheat <ul style="list-style-type: none"> Temperature Min (T_{SMIN}) Temperature Max (T_{SMAX}) Time (T_{SMIN} to T_{SMAX}) (t_s) 	150°C 200°C 60-180 seconds
Time maintained above: <ul style="list-style-type: none"> Temperature (T_L) Time (t_L) 	217°C 60-150 seconds
Peak Temperature (T_P)	260°C
Time within 5°C of actual Peak Temperature (t_p)	20-40 seconds
Ramp-down rate (T_P to T_{SMAX})	6°C/second max
Time 25°C to Peak Temperature	8 minutes max

NOTES:

Based on IPC/JDEC J-STD-020 Revision C.

All temperatures refer to topside of the package, measured on the package body surface.

The actual reflow profile used should be optimized based on the reflow requirements of all components, board design, solder paste formulation and reflow equipment used. Details of recommended handling and manufacturing processes can be found in AN25 SMT Manufacturing Guidelines for SiSonic™ Microphones.

ADDITIONAL NOTES

- MSL (moisture sensitivity level) Class 1.
- Maximum of 3 reflow cycles is recommended.
- In order to minimize device damage:
 - Do not board wash or clean after the reflow process.
 - Do not brush board with or without solvents after the reflow process.
 - Do not directly expose to ultrasonic processing, welding, or cleaning.
 - Do not insert any object in port hole of device at any time.
 - Do not apply over 30 psi of air pressure into the port hole.
 - Do not pull a vacuum over port hole of the microphone.
 - Do not apply a vacuum when repacking into sealed bags at a rate faster than 0.5 atm/sec.
 - Do not directly expose to vapor phase soldering.

MATERIALS STATEMENT

Meets the requirements of the European RoHS directive 2011/65/EC as amended.

Meets the requirements of the industry standard IEC 61249-2-21:2003 for halogenated substances and Knowles Green Materials Standards Policy section on Halogen-Free.

Product is Beryllium Free according to limits specified on the Knowles Hazardous Material List (HSL for Products).

Ozone depleting substances are not used in the product or the processes used to make the product, including compounds listed in Annex A, B, and C of the "Montreal Protocol on Substances That Deplete the Ozone Layer.

RELIABILITY SPECIFICATIONS

Test	Description
Thermal Shock	100 cycles of air-air thermal shock from -40°C to +125°C with 15 minute soaks (IEC 68-2-14)
High Temperature Storage	+105°C environment for 1,000 hours (JESD22-A103)
Low Temperature Storage	-40°C environment for 1,000 hours (JESD22-A119)
High Temperature Bias	+105°C environment while under bias for 1,000 hours (JESD22-A108)
Low Temperature Bias	-40°C environment while under bias for 1,000 hours (JESD22-A108)
Temperature/Humidity Bias	+85°C/85% R.H. environment while under bias for 1,000 hours (JESD22-A101A-B)
Vibration	16 minutes in each X, Y, Z axis from 20 to 2,000 Hz with peak acceleration of 20g (MIL STD-883e, Method 2007.2, Condition A)
ESD-HBM	3 discharges at ±2kV direct contact to I/O pins (ANSI/ESDA/JEDEC JS-001-2014)
ESD-HMM	10 discharges at ±8kV direct contact to lid when unit is grounded (ANSI/ESD SP5.6-2009)
ESD-CDM	3 discharges at ±500V (ANSI/ESDA/JEDEC JS-002-2014)
Reflow	5 reflow cycles with peak temperature of +260°C (JEDEC 22-A113F)
Mechanical Shock	3 pulses of 12,000g in each of the X, Y, and Z directions (IEC 68-2-27 Test Ea)

NOTES:

Microphones meet all acoustic and electrical specifications before and after reliability testing, except sensitivity which can deviate up to 3dB.

After 3 reflow cycles, the sensitivity of the microphones shall not deviate more than 1 dB from its initial value.

Temperature Storage testing is covered by Temperature Bias testing as $T_a = T_j$ for Knowles Microphones

SPECIFICATION REVISIONS

Revision	Specification Changes	Date
A	Initial Release	5/24/2023

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